

**Search Notes**

Application/Control No.

10/817,251

Examiner

Huyen Le

Applicant(s)/Patent under  
Reexamination

LIEN WILEY

Art Unit

3751

**SEARCHED**

Class	Subclass	Date	Examiner
401	21	6/23/2006	HL
	204 205		
	208 210		
	216 219		
	220 263		
	270 281		
	183		
	updated		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
US-PGPUB		6/23/2006	HL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR